

UTC UNISONIC TECHNOLOGIES CO., LTD

26N50

Preliminary

26A, 500V N-CHANNEL **POWER MOSFET**

DESCRIPTION

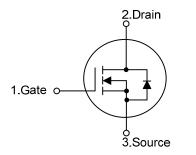
The UTC 26N50 is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC 26N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.

FEATURES

- * $R_{DS(ON)} \le 0.24\Omega$ @ $V_{GS}=10V$, $I_D=13A$
- * High Switching Speed
- * 100% Avalanche Tested

SYMBOL

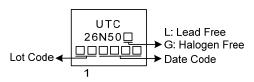


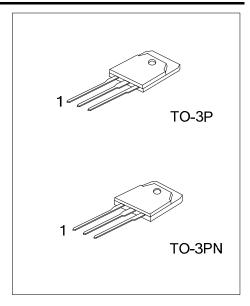
ORDERING INFORMATION

Ordering Number		Deskere	Pin Assignment			Dealing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
26N50L-T3P-T	26N50G-T3P-T	TO-3P	G	D	S	Tube	
26N50L-T3N-T	26N50G-T3N-T	TO-3PN	G	D	S	Tube	
Note: Pin Assignment: G: Gate D: Drain S: Source							

26N50G-T3P-T	
(1)Packing Type	(1) T: Tube
(2)Package Type	(2) T3P: TO-3P, T3N: TO-3PN
(3)Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING





■ ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	500	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current	Continuous (T _C =25°C)	I _D	26 (Note 2)	А
	Pulsed (Note 3)	I _{DM}	96 (Note 2)	А
Avalanche Current (Note 3)		I _{AR}	26	А
Avalanche Energy	Single Pulsed (Note 4)	E _{AS}	1100	mJ
	Repetitive (Note 5)	E _{AR}	29	mJ
Peak Diode Recovery dv/dt (Note 5)		dv/dt	15	V/ns
Power Dissipation		р	290	W
Derate above 25°C		PD	2.33	W/°C
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Drain current limited by maximum junction temperature.

- 3. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 4. L =3.4mH, I_{AS} = 26A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 5. I_{SD} ≤ 26A, di/dt ≤ 200A/µs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ _{JA}	40	°C/W
Junction to Case	θ _{JC}	0.43	°C/W



■ ELECTRICAL CHARACTERISTICS (T_c=25°C, unless otherwise specified)

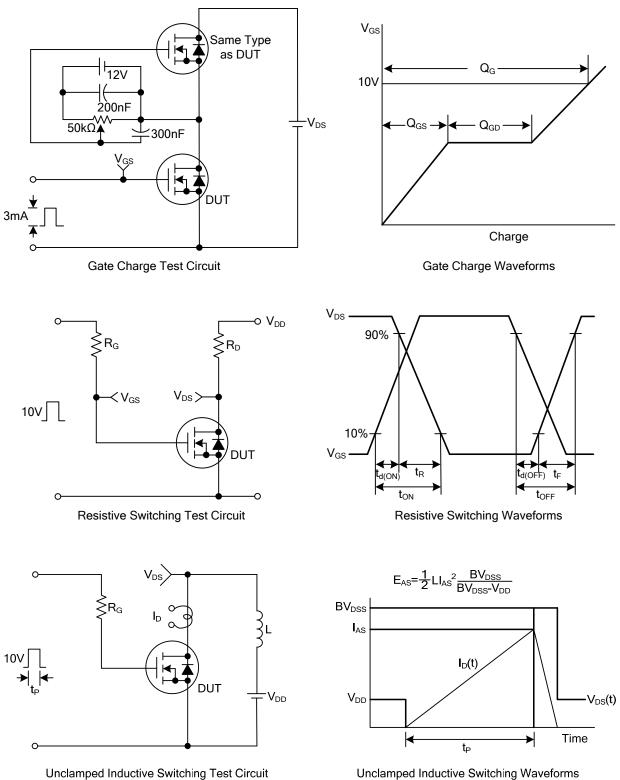
PARAMETER	SYMBOL		MIN	TYP	MAX	UNIT
	STMBUL	TEST CONDITIONS	IVIIIN	ITP	WAX	UNIT
OFF CHARACTERISTICS				1	1	
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	500			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =500V, V _{GS} =0V			50	μA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =+30V, V _{DS} =0V			+100	nA
Reverse	IGSS	V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =13A		0.15	0.24	Ω
DYNAMIC PARAMETERS						
Input Capacitance	CISS			3500	4500	рF
Output Capacitance	Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		520	670	pF
Reverse Transfer Capacitance	C _{RSS}]		55	70	pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	V _{GS} =10V, V _{DS} =400V, I _D =26A		90	120	nC
Gate to Source Charge	Q_{GS}			23		nC
Gate to Drain Charge	Q_{GD}	(Note 1, 2)		52		nC
Turn-ON Delay Time	t _{D(ON)}			80	170	ns
Rise Time	t _R	V _{DD} =250V, I _D =26A, R _G =25Ω		250	500	ns
Turn-OFF Delay Time	t _{D(OFF)}	(Note 1, 2)		200	400	ns
Fall-Time	t _F]		155	320	ns
SOURCE- DRAIN DIODE RATINGS AND (HARACTER	ISTICS	•			
Maximum Body-Diode Continuous Current	ls				24	Α
Maximum Body-Diode Pulsed Current	I _{SM}				96	Α
Drain-Source Diode Forward Voltage	V _{SD}	I _S =26A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time	t _{rr}	I _S =26A, V _{GS} =0V,		250		ns
Body Diode Reverse Recovery Charge	Qrr	dl _F /dt=100A/µs (Note 1)		1.1		μC
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Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



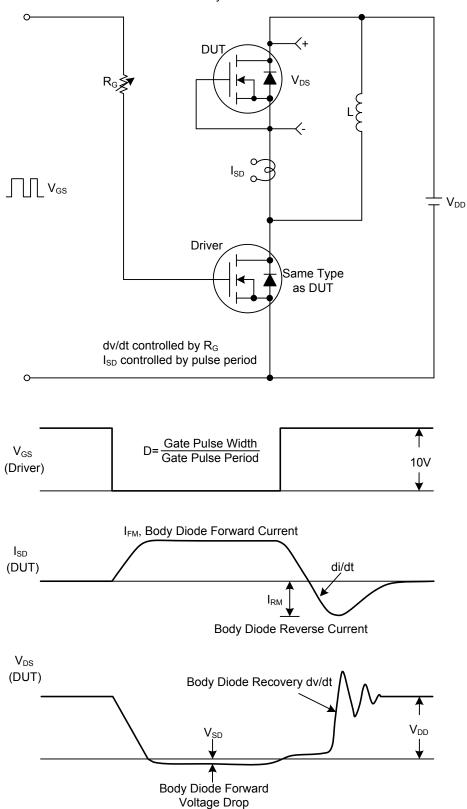
TEST CIRCUITS AND WAVEFORMS



Unclamped Inductive Switching Waveforms



TEST CIRCUITS AND WAVEFORMS(Cont.)



Peak Diode Recovery dv/dt Test Circuit & Waveforms



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